

7N120-E4

Preliminary

Power MOSFET

7.0A, 1200V N-CHANNEL POWER MOSFET

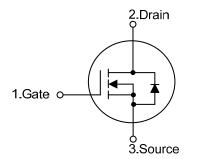
DESCRIPTION

The UTC **7N120-E4** provide excellent $R_{DS(ON)}$, low gate charge and operation with low gate voltages. This device is suitable for use as a load switch or in PWM applications.

■ FEATURES0

- * $R_{DS(ON)} \le 2.6 \ \Omega \ @ V_{GS} = 10V, \ I_D = 3.5A$
- * Low Reverse Transfer Capacitance
- * Fast Switching Capability
- * Avalanche Energy Specified
- * Improved dv/dt Capability, High Ruggedness

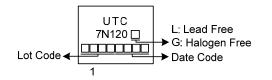
SYMBOL

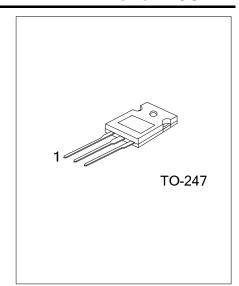


ORDERING INFORMATION

Ordering Number				Dookogo	Pin Assignment			Dealing	
Lead Free		Halogen Free		Package	1	2	3	Packing	
	7N120L-T47-T	7N120G-T47-T		TO-247	G	D	S	Tube	
Note:	Note: Pin Assignment: G: Gate D: Drain S: Source								
	7N120G-T47-T (1)Packing Type (2)Package Type (3)Green Package		(1) T: Tube (2) T47: TO-247 (3) G: Halogen Free and Lead Free, L: Lead Free						

MARKING





ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PAF	RAMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V _{DSS}	1200	V	
Gate-Source Voltage		V _{GSS}	±30	V	
Duain Cumant	Continuous	ID	7	А	
Drain Current	Pulsed (Note 2)	I _{DM}	14	А	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	352	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.65	V/ns	
Power Dissipation		PD	171	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=30mH, I_{AS}=4.85A, V_{DD}=120V, R_G=25 Ω , Starting T_J = 25°C

4. $I_{SD} \le 7.0A$, di/dt $\le 200A/\mu_S$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

4. $I_{SD} \leq 1.0A$, $ui/ul \leq 200A/\mu S$, $v_{DD} \leq Dv_{DSS}$, Starting I_{J} .

THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	θ _{JA} 50		
Junction to Case	θ _{JC}	0.73	°C/W	

ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

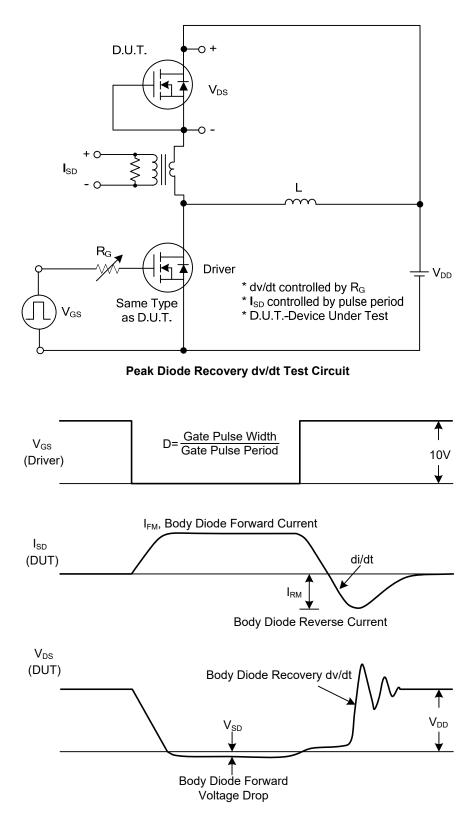
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PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250µA	1200			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =1200V, V _{GS} =0V			10	μA
Gate-Source Leakage Current	I _{GSS}	$V_{GS}=\pm 30V, V_{DS}=0V$			±100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250µA	3.0		5.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =3.5A			2.6	Ω
DYNAMIC CHARACTERISTICS	_		_			
Input Capacitance	CISS			1490		рF
Output Capacitance	Coss	V _{DS} =25V, V _{GS} =0V, f=1MHz		164		рF
Reverse Transfer Capacitance	C _{RSS}] [55		рF
SWITCHING CHARACTERISTICS						
Total Gate Charge (Note 1)	Q_G			77		nC
Gate-Source Charge	Q_{GS}	V_{DS} =960V, V_{GS} =10V, I_{D} =7.0A		21		nC
Gate-Drain Charge	Q_{GD}	(Note 1, 2)		35		nC
Turn-On Delay Time (Note 1)	t _{D(ON)}			28		ns
Turn-On Rise Time	t _R	V _{DD} =100V, V _{GS} =10V,		34		ns
Turn-Off Delay Time	t _{D(OFF)}	I _D =7.0A, R _G =25Ω (Note 1, 2)		208		ns
Turn-Off Fall Time	t _F			70		ns
SOURCE- DRAIN DIODE RATINGS AND CHA	ARACTERIST	CS				
Maximum Continuous Drain-Source Diode					7	^
Forward Current	ls				1	A
Maximum Pulsed Drain-Source Diode					14	А
Forward Current	I _{SM}				14	A
Drain-Source Diode Forward Voltage (Note 1)	V _{SD}	I _S =7.0A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)	t _{rr}	I _S =7.0A, V _{GS} =0V,		960		nS
Body Diode Reverse Recovery Charge	Q _{rr}	dI _F /dt=100A/µs		14.6		μC
Notoo 1, Dulas Test, Dulas width < 200us, Dut	<pre></pre>					

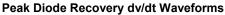
Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

2. Essentially independent of operating temperature.



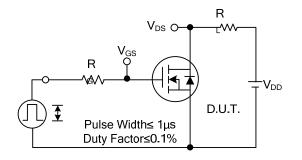
TEST CIRCUITS AND WAVEFORMS



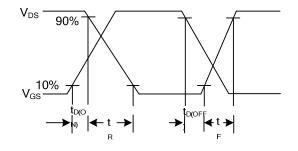


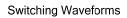


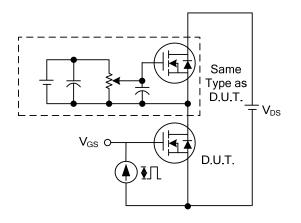
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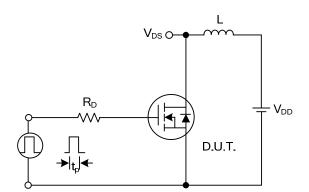
Switching Test Circuit



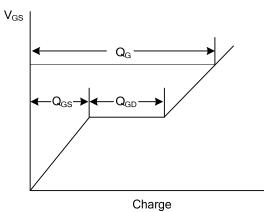




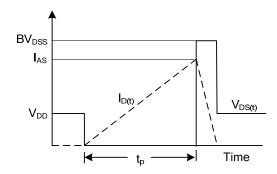
Gate Charge Test Circuit



Unclamped Inductive Switching Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Waveforms



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